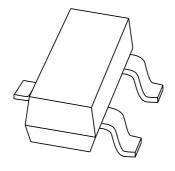
DISCRETE SEMICONDUCTORS

DATA SHEET



PBSS9110T 100 V, 1 A PNP low $V_{CEsat (BISS)}$ transistor

Product data sheet Supersedes data of 2004 May 06 2004 May 13



100 V, 1 A PNP low V_{CEsat (BISS)} transistor

PBSS9110T

FEATURES

- SOT23 package
- Low collector-emitter saturation voltage V_{CEsat}
- High collector current capability: I_C and I_{CM}
- Higher efficiency leading to less heat generation

APPLICATIONS

- · Major application segments
 - Automotive 42 V power
 - Telecom infrastructure
 - Industrial
- DC-to-DC conversion
- · Peripheral drivers
 - Driver in low supply voltage applications (e.g. lamps and LEDs).
 - Inductive load driver (e.g. relays, buzzers and motors).

DESCRIPTION

PNP low V_{CEsat} transistor in a SOT23 plastic package. NPN complement: PBSS8110T.

MARKING

TYPE NUMBER	MARKING CODE(1)
PBSS9110T	*U7

Note

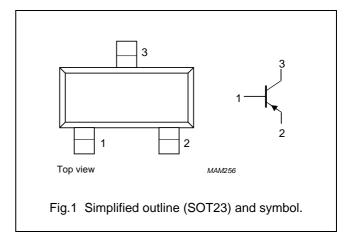
- 1. * = p: Made in Hong Kong.
 - * = t: Made in Malaysia.
 - * = W: Made in China.

QUICK REFERENCE DATA

SYMBOL	PARAMETER	MAX.	UNIT
V _{CEO}	collector-emitter voltage	-100	V
I _C	collector current (DC)	-1	Α
I _{CM}	repetitive peak collector current	-3	Α
R _{CEsat}	equivalent on-resistance	320	mΩ

PINNING

PIN	DESCRIPTION
1	base
2	emitter
3	collector



ORDERING INFORMATION

TYPE NUMBER	PACKAGE			
TIPE NOWIDER	NAME DESCRIPTION VERSION			
PBSS9110T	_	plastic surface mounted package; 3 leads	SOT23	

100 V, 1 A PNP low $V_{CEsat\ (BISS)}$ transistor

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LIMITING VALUES

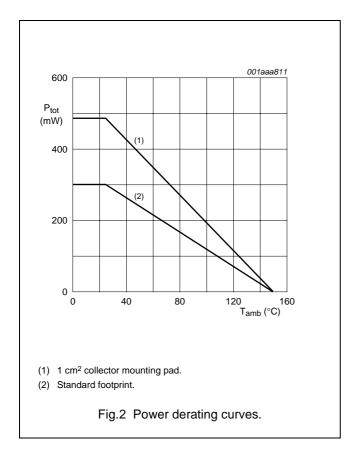
In accordance with the Absolute Maximum Rating System (IEC 60134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V _{CBO}	collector-base voltage	open emitter	_	-120	V
V_{CEO}	collector-emitter voltage	open base	-	-100	V
V _{EBO}	emitter-base voltage	open collector	_	-5	V
I _C	collector current (DC)		-	-1	Α
I _{CM}	peak collector current	limited by T _{j(max)}	-	-3	Α
I _B	base current (DC)		_	-300	mA
P _{tot}	total power dissipation	T _{amb} ≤ 25 °C; note 1	-	300	mW
		T _{amb} ≤ 25 °C; note 2	-	480	mW
Tj	junction temperature		_	150	°C
T _{amb}	operating ambient temperature		-65	+150	°C
T _{stg}	storage temperature		-65	+150	°C

Notes

- 1. Device mounted on a printed-circuit board, single-sided copper, tin-plated, standard footprint.
- 2. Device mounted on a printed-circuit board, single-sided copper, tin-plated and 1 cm² collector mounting pad.

3



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100 V, 1 A PNP low $V_{CEsat\ (BISS)}$ transistor

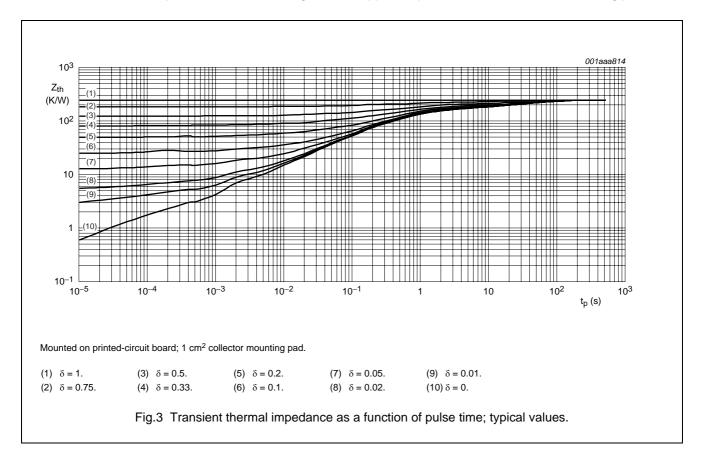
PBSS9110T

THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
R _{th(j-a)}	thermal resistance from junction to	in free air; note 1	417	K/W
	ambient	in free air; note 2	260	K/W

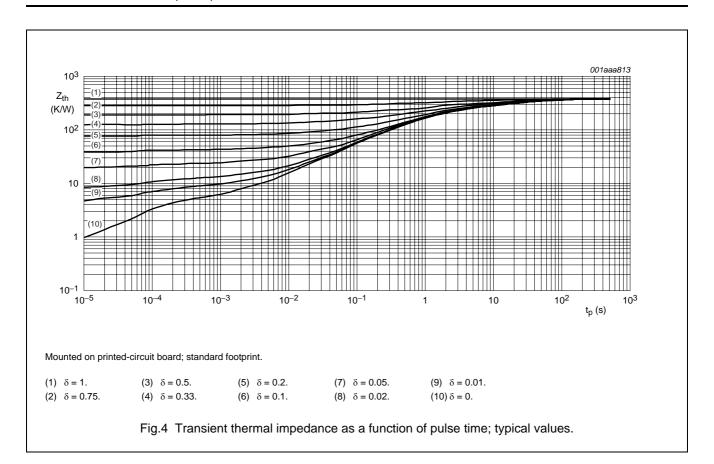
Notes

- 1. Device mounted on a printed-circuit board, single-sided copper, tin-plated and standard footprint.
- 2. Device mounted on a printed-circuit board, single-sided copper, tin-plated and 1 cm² collector mounting pad.



100 V, 1 A PNP low $V_{CEsat\ (BISS)}$ transistor

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100 V, 1 A PNP low $V_{\text{CEsat (BISS)}}$ transistor

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CHARACTERISTICS

 T_j = 25 °C unless otherwise specified.

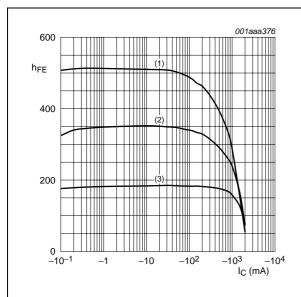
SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
I _{CBO}	collector-base cut-off current	$V_{CB} = -80 \text{ V}; I_E = 0 \text{ A}$	_	_	-100	nA
		$V_{CB} = -80 \text{ V}; I_E = 0 \text{ A}; T_j = 150 ^{\circ}\text{C}$	_	_	-50	μΑ
I _{CES}	collector-emitter cut-off current	$V_{CE} = -80 \text{ V}; V_{BE} = 0 \text{ A}$	_	-	-100	nA
I _{EBO}	emitter-base cut-off current	$V_{EB} = -4 \text{ V}; I_C = 0 \text{ A}$	_	-	-100	nA
h _{FE}	DC current gain	$V_{CE} = -5 \text{ V}; I_{C} = -1 \text{ mA}$	150	-	-	
		$V_{CE} = -5 \text{ V}; I_{C} = -250 \text{ mA}$	150	-	_	
		$V_{CE} = -5 \text{ V}; I_{C} = -500 \text{ mA}; \text{ note 1}$	150	-	450	
		$V_{CE} = -5 \text{ V}; I_{C} = -1 \text{ A}; \text{ note 1}$	125	-	-	
V _{CEsat}	collector-emitter saturation voltage	$I_C = -250 \text{ mA}; I_B = -25 \text{ mA}$	_	-	-120	mV
		$I_C = -500 \text{ mA}; I_B = -50 \text{ mA}$	_	_	-180	mV
		$I_C = -1 \text{ A}$; $I_B = -100 \text{ mA}$; note 1	_	-	-320	mV
R _{CEsat}	equivalent on-resistance	$I_C = -1 \text{ A}$; $I_B = -100 \text{ mA}$; note 1	_	170	320	mΩ
V_{BEsat}	base-emitter saturation voltage	$I_C = -1 \text{ A}; I_B = -100 \text{ mA}$	_	_	-1.1	V
V_{BEon}	base-emitter turn-on voltage	$V_{CE} = -5 \text{ V}; I_{C} = -1 \text{ A}$	_	-	-1	V
f _T	transition frequency	$V_{CE} = -10 \text{ V; } I_{C} = -50 \text{ mA;}$ f = 100 MHz	100	_	_	MHz
C _c	collector capacitance	$V_{CB} = -10 \text{ V}; I_E = I_e = 0 \text{ A};$ f = 1 MHz	_	_	17	pF

Note

1. Pulse test: $t_p \le 300~\mu s;~\delta \le 0.02.$

100 V, 1 A PNP low $V_{CEsat\ (BISS)}$ transistor

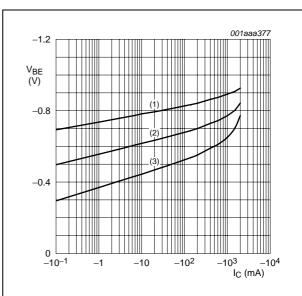
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 $V_{CE} = -10 \text{ V}.$

- (1) T_{amb} = 100 °C.
- (2) $T_{amb} = 25 \, ^{\circ}C$.
- (3) $T_{amb} = -55 \, ^{\circ}C$.

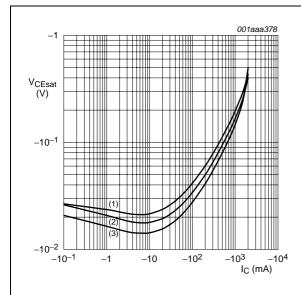
Fig.5 DC current gain as a function of collector current; typical values.



 $V_{CE} = -10 \text{ V}.$

- (1) $T_{amb} = -55 \, ^{\circ}C$.
- (2) $T_{amb} = 25 \, ^{\circ}C$.
- (3) $T_{amb} = 100 \, ^{\circ}C$.

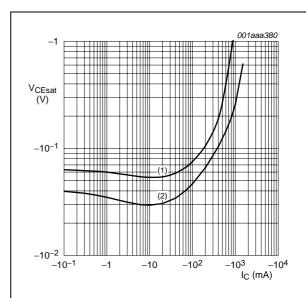
Fig.6 Base-emitter voltage as a function of collector current; typical values.



 $I_{\rm C}/I_{\rm B} = 10.$

- (1) $T_{amb} = 100 \, ^{\circ}C$.
- (2) $T_{amb} = 25 \, ^{\circ}C$.
- (3) $T_{amb} = -55 \, ^{\circ}C$.

Fig.7 Collector-emitter saturation voltage as a function of collector current; typical values.



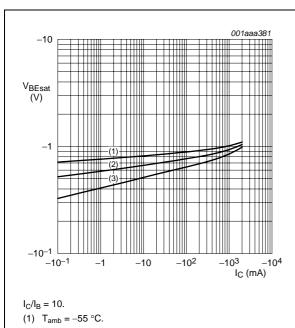
 $T_{amb} = 25 \, ^{\circ}C.$

- (1) $I_C/I_B = 50$.
- (2) $I_C/I_B = 20$.

Fig.8 Collector-emitter saturation voltage as a function of collector current; typical values.

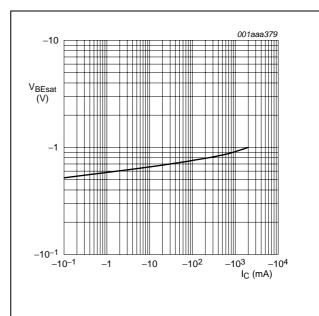
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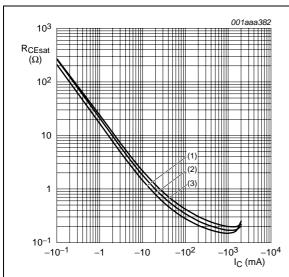
- (2) $T_{amb} = 25 \, ^{\circ}C$.
- (3) $T_{amb} = 100 \, ^{\circ}C$.

Fig.9 Base-emitter saturation voltage as a function of collector current; typical values.



 $I_C/I_B = 20$. $T_{amb} = 25 \,^{\circ}C$.

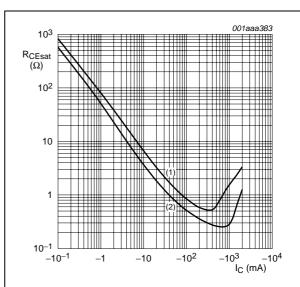
Fig.10 Base-emitter saturation voltage as a function of collector current; typical values.



 $I_{\rm C}/I_{\rm B} = 10.$

- (1) $T_{amb} = -55 \, ^{\circ}C$.
- (2) $T_{amb} = 25 \,^{\circ}C$.
- (3) $T_{amb} = 100 \, ^{\circ}C$.

Fig.11 Equivalent on-resistance as a function of collector current; typical values.



 $T_{amb} = 25 \, ^{\circ}C.$

- (1) $I_C/I_B = 50$.
- (2) $I_C/I_B = 20$.

Fig.12 Equivalent on-resistance as a function of collector current; typical values.

100 V, 1 A PNP low $V_{CEsat\ (BISS)}$ transistor

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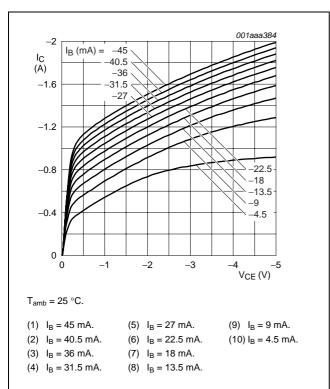
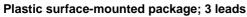


Fig.13 Collector current as a function of collector-emitter voltage; typical values.

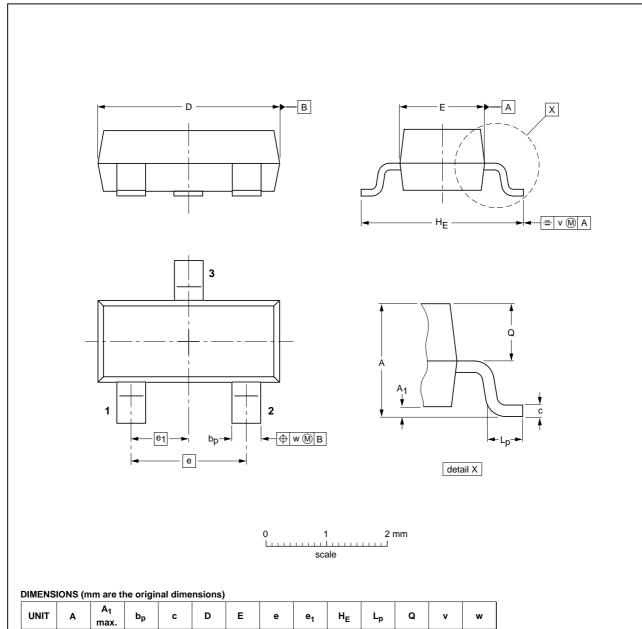
100 V, 1 A PNP low $V_{CEsat\ (BISS)}$ transistor

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PACKAGE OUTLINE



SOT23



OUTLINE	REFERENCES			EUROPEAN	ISSUE DATE	
VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE
SOT23		TO-236AB				04-11-04 06-03-16

0.95

1.9

0.45

0.55

0.2

0.1

2004 May 13 10

0.48

0.38

0.15

1.1

0.9

100 V, 1 A PNP low V_{CEsat (BISS)} transistor

PBSS9110T

DATA SHEET STATUS

DOCUMENT STATUS ⁽¹⁾	PRODUCT STATUS ⁽²⁾	DEFINITION
Objective data sheet	Development	This document contains data from the objective specification for product development.
Preliminary data sheet	Qualification	This document contains data from the preliminary specification.
Product data sheet	Production	This document contains the product specification.

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